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Product Specification 产品规格书

YR350QV003M-01

3. 5" 240(V)*320(H)*3(RGB) TFT LCD MODULE Nov 21, 2017

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REVISION HISTORY

Rev	Description	Page	Date
1.0	Initial Release	All	2017-11-21
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1. GENERAL DESCRIPTION

1.1 DESCRIPTION

YR350QV003M-01 is a transmissive type color active matrix TFT (Thin Film Transistor) liquid crystal display (LCD) that uses amorphous silicon TFT as a switching device. This model is composed of a TFT-LCD module (TFT-LCD panel, driver IC and FPC), a back-light unit and. The resolution of 3.5" contains 240X320RGB pixels and can display up to 16.7M colors.

1.2 GENERAL INFORMATION

Items	Specification	Unit	Note
Display mode	TFT Transmissive, Positive, NW,TN	-	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Drive element	a-Si TFT active matrix		
LCM outline size	76.84(H) x 63.84(V) x 3.27(T)	mm	Note (1)(2)
Active area	70.08(H)X52.56(V)	mm	-
Number of pixels	320*3RGB(H)X240(V)	pixels	-
Pixel arrangement	RGB stripe	1	-
Pixel size	0.219(W) x 0.219 (H)	mm	-
Display color	16.7M	color	-
Viewing direction	12 Viewing	-	-
Controller / Driver	/ /-	-	-
Data interface	24 BIT RGB Interface	-	
Backlight	6 White LEDs In Series	-	
Weight	TBD	g	

Notes:

- (1) Touch panel and back-light unit are included.
- (2) FPC no included. (Refer to the module outline dimension for further information). Please see module specification drawing in Page14 for more details.

2. ABSOLUTE MAXIMUM RATING

(Ta=25±2°C, Vss=GND=0V)

Characteristics	Symbol	Min.	Max.	Unit	Notes
Power Supply Voltage 1	VDD1	-	-	V	
Power Supply Voltage 2	VDD2	-	-	V	$-\frac{1}{2}$
Power Supply Voltage 3	VDD3	-	-	V	$\langle \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$
Power Supply Voltage 4	HS_VCC	-	-	V	
Power Supply Voltage 5	VSP	-	- /	V	
Power Supply Voltage 6	VSN	-	-(/)	V	
TFT Gate On voltage	VGH	14	+16	V	
TFT Gate Off voltage	VGL	-12	-8	V	
Logic Signal Input Voltage	V_{IN}	-	VDD1+0.3	V	
HS Input Voltage	V_{IN}	-0.3	+2.0	V	
Backlight Forward Current	I _F	-	20	mA	
Operating Temperature	T _{OPR}	-20	+70	°C	(1), (3)
Storage Temperature	T _{STG}	-30	+80	°C	(2), (3)
Humidity	RH	\-	90	%	Max. 60 °C

Notes:

- (1) In case of below 0°C, the response time of liquid crystal (LC) becomes slower and the color of panel becomes darker than normal one. Level of retardation depends on temperature, because of the LC characteristics.
- (2) If product is exposed to high temperatures for extended time, there is a possibility of the polarizer film damage which could degrade the optical characteristics.
- (3) Permanent damage to the device may occur if maximum values are exceeded or reverse voltage is loaded.
 - Functional operation should be restricted to the conditions described under normal operating conditions.

3. ELECTRICAL CHARACTERISTICS

3.1 LCM DC CHARACTERISTICS

(Ta=25±2°C)

Characteristics	Symbol	Min.	Тур.	Max.	Unit	Note
Power Supply Voltage 1	VDDIO	-	-	-	V	
Power Supply Voltage 2	VDD	3.1	3.3	3.6	V	
Power Supply Voltage 3	VDD	3.1	3.3	3.6	V	
Power Supply for MTP	VPP	-	-	- 📈	V	
Current Consumption	I _{DD}	-	40	-	mA	Normal mode
Current Consumption	I _{DD-SLEEP}		1	V _A	mA	Sleep mode
Input voltage "L" Level	V_{IL}	GND	• •	0.3VDD1	٧	VDD1=1.65~
Input voltage "H" Level	V _{IH}	0.7VDD1		VDD1	V	3.3
Output voltage "L" Level	V_{oL}	0	X	0.2VDD1	V	I _{OL} =1mA
Output voltage "H" Level	V_{oH}	0.8VDD1		VDD1	V	I _{OH} =-1mA

3.2 BACK-LIGHT UNIT CHARACTERISTICS

The back-light system is an edge-lighting type with 6 white LEDs. The characteristics of the back-light are shown in the following tables.

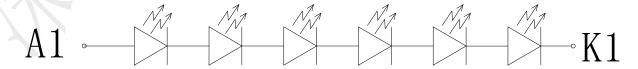
(Ta=25±2°C)

Characteristics	Symbol	Condition	Min.	Type	Max.	Unit	Notes
Forward Voltage	Vf	I _L =20mA	17.4	19.2	20.4	V	-
Forward current	l _L	1		20	-	mA	-
Luminance	Lv	I _L =20mA	260	300	340	cd/m ²	-
LED life time	-	I _L =20mA	-	15,000	-	Hr	Note 1

Note:

(1) The "LED life time" is defined as the module brightness decrease to 50% of original brightness at I_L =20mA. The LED life time could be decreased if operating I_L is larger than 20mA.

Backlight circuit diagram shown in below:



4. OPTICAL CHARACTERISTICS

The following items are measured under stable conditions. The optical characteristics should be measured in a dark room.

Measuring equipment: BM-5AS, BM-7, EZ-Contrast.

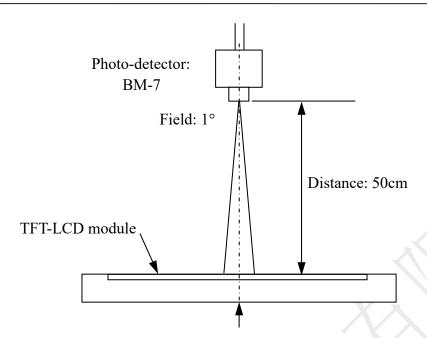
(Ta=25±2°C)

Parame	ter	Symbol	Condition	Min.	Тур.	Max.	Unit	Note
	Contrast Ratio (Center point)		-	-	500	-	-	BM-7 Note(2)
Luminance o (Center po		L_{w}	B/L on	TBD	300	-	cd/m ²	BM-7
Luminance ur	niformity	U _W		80	1	-	%	BM-7 Note(3)
Response	Time	Tr + Tf		-	20	30	ms	BM-5AS Note(4)
	White	W_{X}	$\theta = 0.$	0.282	0.312	0.342	-	BM-7 Note(5)
	vviile	W_X	Normal viewing	0.319	0.349	0.379		
	Red	R_X	angle B/L On Note(1)	0.609	0.639	0.669		
Color		R_Y		0.314	0.344	0.374		
Chromaticity (CIE 1931)	Green	G _X		0.264	0.294	0.324		
,		G_{y}		0.557	0.587	0.617		
	Dlug	B _X	_'	0.102	0.132	0.162		
	Blue	B _Y		0.319	0.349	0.379		
	Hor.	θ_{L}		-	45	1		
Viewing	HUI.	θ_{R}	C/D>10	-	45	-	Deg	EZ Contrast
Angle	Ver.	θ_{u}	C/R≥10	-	15	-		Note(6)
	vei.	θ_{D}		-	35	-		
Optima \	/iew Dire	ction		1	12 :00			Note(7)

^{*} This condition will be changed by the evaluation circumstance. If product is exposed to high temperatures for extended time, there is a possibility of the polarizer film damage which could degrade the optical characteristics.

Notes:

(1) Test Equipment Setup: After stabilizing and leaving the panel alone at a given temperature for 30min, the measurement should be executed. Measurement should be executed in a stable, windless, and dark room 30min after lighting the back-light. This should be measured in the center of screen.



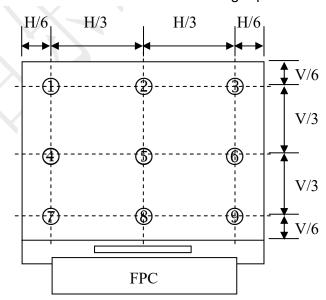
The Center of the screen

(2) Definition of Contrast Ratio (CR):

(3) Definition of Luminance Uniformity: Active area is divided into 9 measuring areas (Shown in below), every measuring point is placed at the center of each measuring area.

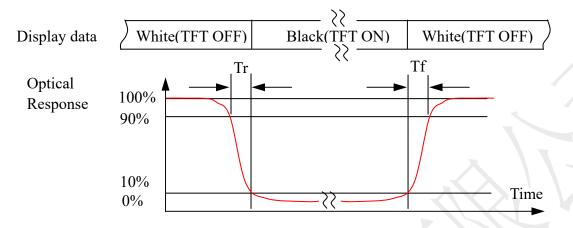
Luminance Uniformity = Min Luminance of white among 9-points

Max Luminance of white among 9-points x100%

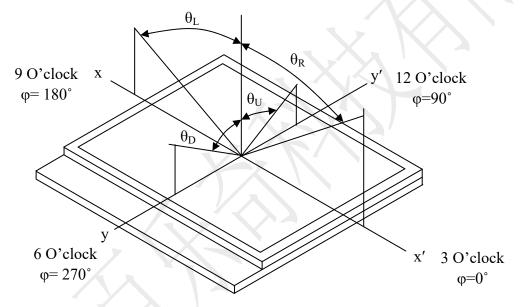


The spot locations for luminance measurement

(4) Definition of Response time: Sum of Tr and Tf.

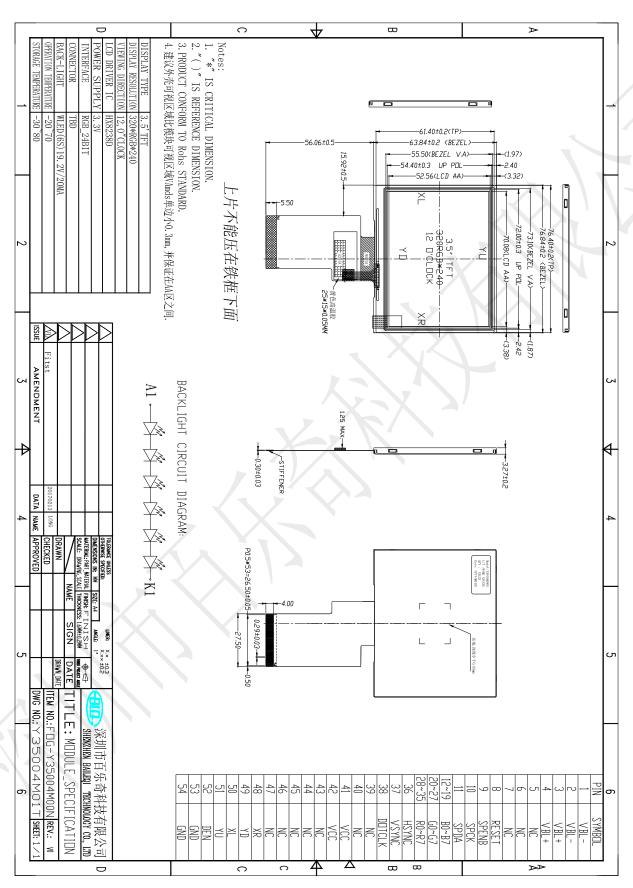


(5) Definition of Viewing Angle: The viewing angle range that the CR≥10.



- (6) Definition of Color Chromaticity (CIE 1931)Color coordinate of white & red, green, blue at center point.
- (7) The different Rubbing Direction will cause the different optima view direction.

5. MODULE OUTLINE DIMENSION



6. MODULE INTERFACE DESCRIPTION

Pin No.	Symbol	I/O	Function
1~2	VBL-	P	Cathode for LEDs
3~4	VBL+	Р	Anode for LEDs
5~7	NC	I	No Connection
8	RESET	Ι	Reset signal
9	SPENB	Ι	Chip Selection
10	SPCK	I	Serial communication clock input
11	SDA	I/O	Serial communication data input.
12~19	B0~B7	I	Blue Data bus
20~27	G0~G7	Ι	Green Data bus
28~35	R0~R7	I	Red Data bus
36	HS	Ι	Horizontal Sync input. Negative polarity.
37	VS	I	Vertical Sync input. Negative polarity
38	DOTCLK	I	Clock signal. Latching data at the rising edge.
39~40	NC	I	No Connection
41~42	VCC	P	Power supply for charge pump circuit.
43~47	NC	I	No Connection
48	NC(XR)	I	No Connection(Right side of TP)
49	NC(YD)	I	No Connection(Down side of TP)
50	NC(XL)	I	No Connection(Left side of TP)
51	NC(YU)	I	No Connection(Up side of TP)
52	DEN	I	Data Enable
53~54	GND	I	Ground for digital circuits

I: input, O: output, P: power, C: capacitor.

7. REFERENCE APPLICATION CIRCUIT

Please consult our technical department for detail information.

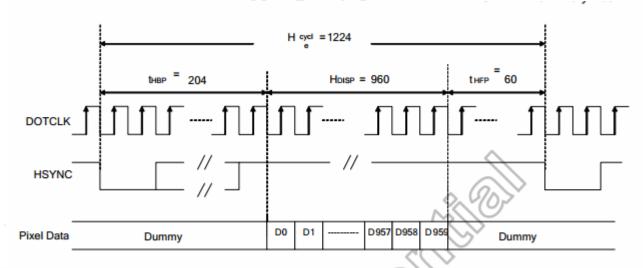
8. TIMINGS FOR 24-bit RGB Interface

8.1 Pixel Timing

Characteristics	Symbol	M	in.	Ту	/p.	Ma	ax.	Unit
Characteristics	Symbol	24 bit	8 bit	24 bit	8 bit	24 bit	8 bit	Oiiit
DOTCLK Frequency	fDOTCLK	-	-	6.5	19.5	10	30	MHz
DOTCLK Period	tDOTCLK	100	33.3	154	51.3	-	-	ns
Vertical Sync Setup Time	tvsys	20	10	-	-	-	-	ns
Vertical Sync Hold Time	tvsyh	20	10	-	-	-	-	ns
Horizontal Sync Setup Time	thsys	20	10	-	-	-	-	ns
Horizontal Sync Hold Time	thsyh	20	10	-	-	-	-	ns
Phase difference of Sync Signal Falling Edge	thv		1		-	24	40	tDOTCLK
DOTCLK Low Period	tCKL	50	15	-	-	-	-	ns
DOTCLK High Period	tCKH	50	15	-	-	-	-	ns
Data Setup Time	tds	12	10	-	-	-	-	ns
Data hold Time	tdh	12	10	-	-	-	-	ns
Reset pulse width	tRES	1	0					μS

Note: External clock source must be provided to DOTCLK pin of HX8238-D. The driver will not operate if absent of the clocking signal.

8.2 SYNC Mode



(1) Horizontal Data Transaction Timing

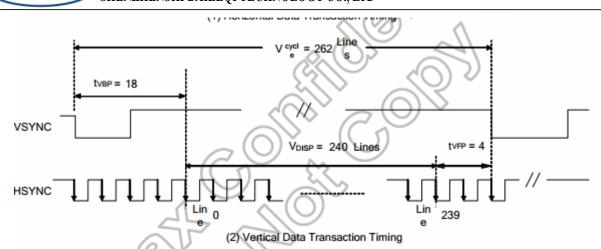
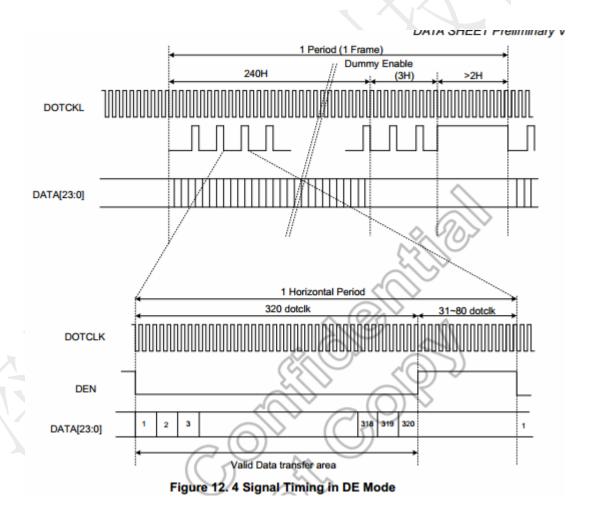


Figure 12.3 Data Transaction Timing in Serial RGB (8 bit) Interface (SYNC Mode)

8.3 DE Mode



9. RELIABILITY TEST CONDITIONS

No.	Test Item	Test Condition	Notes
1	High Temperature Storage	+80°C / 120H	Inspection after
2	Low Temperature Storage	-30°C / 120H	2~4h storage at room temperature,
3	High Temperature Operating	+70°C / 120H	the sample shall be
4	Low Temperature Operating	-20°C / 120H	free from defects: 1.Air bubble in the
5	Temperature Cycle	Ta=-10°C~+25~+50°C,10 Cycle,per30min	LCD; 2.Sealleak;
6	High Temperature /Humidity storage	50+5°C x 90%RH / 120H	3.Non-display; 4. Missing
7	Vibration Test	Frequency: 10Hz~55Hz~10Hz Amplitude:1.5mm, 2 hours for each direction of X, Y, Z	segments; 5.Glass crack; 6.The surface shall
8	Packing Drop Test	Drop to the ground from 1m height, 1 corner, 3 edges, 6 surfaces.	be free from damage.
9	ESD test	Voltage:±8KV R: 330Ω C: 150pF Air discharge, 10time	7. The electrical characteristics requirements shall be satisfied.

Remarks:

- (1) The test samples should be applied to only one test item.
- (2) Sample size for each test item is 5~10pcs.
- (3) For High Temperature/Humidity storage test, pure water (resistance>10M Ω) should be used.
- (4) In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judge as a good part.
- (5) Failure judgment criterion: basic specification, electrical characteristic, mechanical characteristic, optical characteristic.

10. PACKING SPECIFICATION

TBD

11. INSPECTION CRITERION

Inspection item			Judgement standard				
			9		Acceptabl	e number	
	·			Category	A zone	B zone	
	Black spot,White spot,Pinhole Foreign Particle, Bubble andParticle Between polarizer glass, scratch on p	and $\Phi = (a+b)/2 (mm)$	A B C D		Ignored 2 0	Ignored	
	Bright spot		0.15<Φ≦0.20 N		N≤0	Ignored	
	Pixel point defect	Dark spot/ Black spot		0.15<Φ≦0.20	N≤2	-	
1		Attached to the two pixels are bright spots		0.15<Φ≦0.20	N≤0		
		Even a two pixel is dark	Even a two pixel is dark		N≤0		
		Pixel total number 0.15<Φ≦0.20		0.15<Φ≦0.20	N≤2		
		Note1: the spot defect caused by foreign matter is judged according to the defect of the foreign body. Note 2: when the light is not wired to show the type of defects.					
2	Black line,White line,Bubble and Particle Between Polarizerand	W	A B C D	W≦0.03L≦3.0 0.03 <w≦0.05 l≦3.0<br="">0.05<w< td=""><td>Ignored 2 0</td><td>Ignored</td></w<></w≦0.05>	Ignored 2 0	Ignored	
	glass, Scratch onpolarizer	L W:Width, L:Length(mm)		Total defective point(B,C)	2		
3	Contrast variation	$ \begin{array}{c} $	A B C D	$\begin{array}{c} \Phi \leq 0.2 \\ 0.2 < \Phi \leq 0.3 \\ 0.3 < \Phi \leq 0.4 \\ 0.4 < \Phi \end{array}$ Total defective point(B,C)	Ignored 2 1 0 3	Ignored	
4	Bubble insidecell			any size	none	none	
5	Polarizer defect (if Polarizer is used)	Scratch and damage on polarizer, particle on polarizer or between polarizer and glass.	Refer to item 1 and item 2.				
		Bubble, dent and convex	A B C	$\begin{array}{c} \Phi \leqq 0.2 \\ 0.2 < \Phi \leqq 0.3 \\ 0.3 < \Phi \end{array}$ Total defective point(B,C)	Ignored 5 0 2	Ignored	

		Judgement standard			
	Inspection item	Category	Acceptable number		
		Calegory	A zone	B zone	
	Surplusglass	①Stage surplus glass	b≦0.3mm		
6		②Surrounding surplus glass	Should not influence ou	utline dimension and assembling.	
	MURA	①MURA	Naked eye examination: red, green, blue screen does not allow the appearance, black screen requires visual is not obvious, the specific reference limit samples. Note: the principle of closing the sample is to be installed on the whole machine and the end user will not find it in the normal usage scenario. Inspection basis: 6%ND (MURA mainly in the black screen and indoor light is relatively dark will be found, it is recommended to turn off the indoor lighting inspection.)		
7		@Point Black / White / point(MURA)	_	<i>i</i> ≦2;	

			Judgment standard			
	Inspection item			Category(application: B zone)		
		①The front of lead terminals	Α	If a ≦ t and b ≦ 1.0, c is not limited		
			В	a≦t, 1≦b≦2mm, c≦3mm		
		b	С	If glass crack cover alignment mark, b≦0.5mm.		
		w t a	D	Crack at two sids of lead terminals should not cover patterns and alignment mark		
		②Surrounding				
		crack—non-contact side				
		c b a t	b < Inner borderline of the seal			
		Inner border line of the seal				
Glass Outer border line of the seal		Outer border line of the seal Surrounding crack— contact	t b < Outer borderline of the seal			
8	defect crack	side	b Catal Bolderinia of the scal			
		Inner border line of the seal Outer border line of the seal				
4		4)Corner	Α	$a \le t, b \le 3.0, c \le 3.0$		
1			*Glas	ss crack should not cover patterns used for		
		w c				

		Inspection item	Judgement standard		
		Component soldering:No cold soldering, short/open circuit, burr, tin ball. The flat encapsulation component position deviation must be less than 1/2 width of the pin (Pic.1); The sheet component deviation: pin deviates from the pad and contact with the near components is not permitted (Pic.2)	Component L≤W/2 W		
9	FPC defect	lead defect: The lead lack must be less than 1/2of its width; The lead burr must be less than 1/2 of the seam; Impurities connect with the near leads is not permitted	Soldering pad Lead L2>0 Component L1>0		
		Connector soldering: Soldering tin is at contact position of the plug and socket is not permitted No foundation is scald Serious cave distortion on plug and socket contact pin is not permitted	head Base Board Soldering tin is not permit in this area Soldering tin is not permit in this area Socket Base Board		

12. GENERAL PRECAUTIONS

1.1 HANDING

- (1) When the module is assembled, it should be attached to the system firmly. Be careful not to twist and bent the module.
- (2) Refrain from strong mechanical shock and / or any force to the module. In addition to damage, this may cause improper operation or damage to the module and back-light unit.
- (3) Note that display modules are very fragile and could be easily damaged. Do not press or scratch the surface harder than a HB pencil lead.
- (4) Wipe off water droplets or oil immediately. If you leave the droplets for a long time, straining and discoloration may occur.
- (5) If the display module surface becomes contaminated, breathe on the surface and gently wipe it with a soft dry cloth. If it is heavily contaminated, should be wiped by moisten cloth with isopropyl alcohol or ethyl alcohol solvents, DO NOT with water, ketone type materials (e.g. acetone), aromatic, toluene, ethyl acid or methyl chloride, and so on.
- (6) If the liquid crystal material leaks from the panel, it should be kept away from the eyes or mouth. In case of contact with hands, legs or clothes, it must be washed away thoroughly with soap.
- (7) Use finger-stalls with sort gloves in order to keep display clean during the incoming inspection and assembly process.
- (8) Protection film for polarizer on the module shall be slowly peeled off just before use so that the electrostatic charge can be minimized.
- (9) Do not touch directly conductive parts such as the CMOS LSI pad and the interface terminals with bare hands, therefore operations should be grounded whenever he/she comes into contact with the modules.
- (10) Do not exceed the absolute maximum rating value. (The supply voltage variation, input voltage variation, variation in part contents and environmental temperature, and so on), otherwise the module may be damaged.

1.2 SOLDERING

- (1) Use soldering irons with proper grounding and no leakage.
- (2) For No RoHS Product: soldering temperature is 290~350°C, soldering time is 3~5s; for RoHS Product: soldering temperature is 340~370°C, soldering time is 3~5s.
- (3) If soldering flux is used, be sure to remove any remaining flux after soldering (This does not apply in the case of a non-halogen type of flux).

1.3 STORAGE

- (1) DO NOT leave the module in high temperature and high humidity for a long times, keep the temperature from 0°C to 35°C and relative humidity of less than 60%.
- (2) It is highly recommended to store the module in a dark place. The Liquid crystal is deteriorated by ultraviolet, DO NOT leave it in direct sunlight and strong ultraviolet ray for many hours.
- (3) The polarizer surface should not come in contact with any other objects.